


Search Notes 	Application/Control No. 10575171	Applicant(s)/Patent Under Reexamination KIM, YOUNG-LAK
	Examiner Munjal Patel	Art Unit 2617

SEARCHED			
Class	Subclass	Date	Examiner
370	310	3-26-2008	NR
370	328	3-26-2008	NR
370	338	3-26-2008	NR
370	422.1	3-26-2008	NR
455	403	3-26-2008	NR
455	422.1	3-26-2008	NR
455	436	3-26-2008	NR
455	437	3-26-2008	NR
455	439	3-26-2008	NR
370	338	6/9/2008	mp
455	422	6/6/2008	mp
375	220-222	6/9/2008	mp
370	335,441,479	6/9/2008	mp
455	439, 403, 422.1, 436, 437, 422	12/4/2008	mp
370	338, 335, 441, 479, 422.1, 328, 310	12/4/2008	mp

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST History	4-9-2008	NR
EAST Search	6/5/2008	mp
IEEE database	6/5/2008	mp
PLUS Search	6/5/2008	mp
PALM Search	6/6/2008	mp
EAST Search	12/2/2008	mp
PALM Search	12/2/2008	mp

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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